Randomized Least Squares Regression: Combining Model- and Algorithm-Induced Uncertainties

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Least Squares/Regression Models

Given: Design matrix $\boldsymbol{X} \in \mathbb{R}^{n \times p}$ with $\operatorname{rank}(\boldsymbol{X}) = p$

Gaussian linear regression model

$$\mathbf{y} = \mathbf{X} \boldsymbol{\beta}_0 + \boldsymbol{\epsilon}, \qquad \boldsymbol{\epsilon} \sim \mathcal{N}(\mathbf{0}, \sigma^2 \boldsymbol{I}_n)$$

Unknown parameter vector β_0

2 Least squares problem

$$\min_{\boldsymbol{\beta}} \|\boldsymbol{X}\boldsymbol{\beta} - \boldsymbol{y}\|_2$$

Unique maximum likelihood estimator $\hat{oldsymbol{eta}} = (oldsymbol{X}^{\, au} oldsymbol{X})^{-1} oldsymbol{X}^{\, au} oldsymbol{y}$

Sandomized (row compression) algorithm

$$\min_{\boldsymbol{\beta}} \|\boldsymbol{S}(\boldsymbol{X}\boldsymbol{\beta} - \boldsymbol{y})\|_2$$

Minimal norm solution $ilde{oldsymbol{eta}} = (oldsymbol{S}oldsymbol{X})^\dagger\,(oldsymbol{S}oldsymbol{y})$

Objective

Determine combined mean and variance of $\tilde{\beta}$ w.r.t.

- Gaussian linear model $\boldsymbol{\varepsilon} \sim \mathcal{N}(\boldsymbol{0}, \sigma^2 \boldsymbol{I}_n)$
- Randomized row compression **S**

Inspiration

Ping Ma, Michael Mahoney, Bin Yu A statistical perspective on algorithmic leveraging J. Mach. Learn. Res., vol. 16, pp 861-911 (2015)

Overview

Existing work Examples Structural perturbation bounds Model-induced uncertainty, conditioned on algorithm-induced uncertainty Combined model-induced and algorithm-induced uncertainty Summary

Existing Work

(Numerical) row-compression methods for least squares

Drineas, Mahoney, Muthukrishnan 2006 Zhou, Lafferty, Wasserman 2007 Boutsidis, Drineas 2009 Drineas, Mahoney, Muthukrishnan, Sarlós 2011 Meng, Saunders, Mahoney 2014 Bartels, Hennig 2016 Becker, Kawas, Petrick, Ramamurthy 2017

Statistical properties

Ma, Mahoney, Yu 2015 Raskutti, Mahoney 2016 Ahfock, Astle, Richardson 2017 Thanei, Heinze, Meinshausen 2017 Lopes, Wang, Mahoney 2018 Examples

Model-Induced Uncertainty

Gaussian linear model: $\mathbf{y} = \mathbf{X} \boldsymbol{\beta}_0 + \boldsymbol{\epsilon}$ with $\boldsymbol{\epsilon} \sim \mathcal{N}(0, \sigma^2 \boldsymbol{I}_n)$ Design matrix:

$$\boldsymbol{X} = \begin{pmatrix} 1 & 0 \\ 0 & 1 \\ 1 & 0 \\ 0 & 0 \end{pmatrix}, \qquad \boldsymbol{X}^{\dagger} = (\boldsymbol{X}^{T} \boldsymbol{X})^{-1} \boldsymbol{X}^{T} = \begin{pmatrix} \frac{1}{2} & 0 & \frac{1}{2} & 0 \\ 0 & 1 & 0 & 0 \end{pmatrix}$$

Left inverse:
$$\boldsymbol{X}^{\dagger}\boldsymbol{X} = \boldsymbol{I} = \begin{pmatrix} 1 & 0 \\ 0 & 1 \end{pmatrix}$$

Maximum likelihood estimator: $\hat{\boldsymbol{\beta}} = \boldsymbol{X}^{\dagger} \boldsymbol{y}$ Unbiased estimator: $\mathbb{E}_{\boldsymbol{y}}[\hat{\boldsymbol{\beta}}] = \boldsymbol{X}^{\dagger} \mathbb{E}_{\boldsymbol{y}}[\boldsymbol{y}] = \boldsymbol{X}^{\dagger} \boldsymbol{X} \boldsymbol{\beta}_{0} = \boldsymbol{\beta}_{0}$ Variance: $\mathbb{V}ar_{\boldsymbol{y}}[\hat{\boldsymbol{\beta}}] = \boldsymbol{X}^{\dagger} \mathbb{V}ar_{\boldsymbol{y}}[\boldsymbol{y}] (\boldsymbol{X}^{\dagger})^{T} = \sigma^{2} \begin{pmatrix} \frac{1}{2} & 0\\ 0 & 1 \end{pmatrix}$ Model-Induced Uncertainty Conditioned on Algorithm-Induced Uncertainty (1)

$$\min_eta \| m{S}m{X}m{eta} - m{S}m{y} \|_2$$
 has solution $\ ilde{m{eta}} = (m{S}m{X})^\daggerm{S}m{y}, \quad \mathbb{E}_m{y}[m{y}] = m{X}m{eta}_0$

Sketching preserves rank: rank(SX) = rank(X)

$$\boldsymbol{S}\boldsymbol{X} = \begin{pmatrix} 1 & 0 & 0 & 0 \\ 0 & 1 & 0 & 0 \end{pmatrix} \begin{pmatrix} 1 & 0 \\ 0 & 1 \\ 1 & 0 \\ 0 & 0 \end{pmatrix} = \begin{pmatrix} 1 & 0 \\ 0 & 1 \end{pmatrix} = (\boldsymbol{S}\boldsymbol{X})^{\dagger}$$

Unbiased estimator:

$$\mathbb{E}_{\boldsymbol{y}}\left[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}\right] = (\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S} \ \mathbb{E}_{\boldsymbol{y}}[\boldsymbol{y}] = (\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S}\boldsymbol{X}\boldsymbol{\beta}_{0} = \boldsymbol{\beta}_{0}$$

Variance has increased:

$$\operatorname{Var}_{\boldsymbol{y}}\left[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}\right] = \sigma^{2}(\boldsymbol{S}\boldsymbol{X})^{\dagger} \boldsymbol{S} \left((\boldsymbol{S}\boldsymbol{X})^{\dagger} \boldsymbol{S}\right)^{T} = \sigma^{2} \begin{pmatrix} 1 & 0 \\ 0 & 1 \end{pmatrix} \succeq \sigma^{2} \begin{pmatrix} \frac{1}{2} & 0 \\ 0 & 1 \end{pmatrix}$$

Model-Induced Uncertainty Conditioned on Algorithm-Induced Uncertainty (2)

Sketching causes loss of rank: rank(SX) < rank(X)

$$\boldsymbol{S}\boldsymbol{X} = \begin{pmatrix} 1 & 0 & 0 & 0 \\ 0 & 0 & 0 & 1 \end{pmatrix} \begin{pmatrix} 1 & 0 \\ 0 & 1 \\ 1 & 0 \\ 0 & 0 \end{pmatrix} = \begin{pmatrix} 1 & 0 \\ 0 & 0 \end{pmatrix} = (\boldsymbol{S}\boldsymbol{X})^{\dagger}$$

Biased estimator:

$$\mathbb{E}_{\boldsymbol{y}}\left[\tilde{\boldsymbol{\beta}} \,\middle|\, \boldsymbol{S}\right] = (\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S}\boldsymbol{X}\boldsymbol{\beta}_{0} = \begin{pmatrix} 1 & 0 \\ 0 & 0 \end{pmatrix} \boldsymbol{\beta}_{0} \neq \boldsymbol{\beta}_{0}$$

Variance is singular:

$$\operatorname{Var}_{\boldsymbol{y}}\left[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}\right] = \sigma^{2}(\boldsymbol{S}\boldsymbol{X})^{\dagger} \boldsymbol{S} \left((\boldsymbol{S}\boldsymbol{X})^{\dagger} \boldsymbol{S}\right)^{T} = \sigma^{2} \begin{pmatrix} 1 & 0 \\ 0 & 0 \end{pmatrix}$$

Model-Induced Uncertainty Conditioned on Algorithm-Induced Uncertainty (3)

 $\mathsf{min}_\beta \, \| \boldsymbol{S}(\boldsymbol{X} \boldsymbol{\beta} - \boldsymbol{y}) \|_2 \text{ has solution } \quad \tilde{\boldsymbol{\beta}} = (\boldsymbol{S} \boldsymbol{X})^\dagger \boldsymbol{S} \, \boldsymbol{y}, \quad \, \mathbb{E}_{\boldsymbol{y}}[\boldsymbol{y}] = \boldsymbol{X} \boldsymbol{\beta}_0$

Summary: Model-induced uncertainty conditioned on **S**

• Sketching preserves rank: $\operatorname{rank}(\boldsymbol{SX}) = \operatorname{rank}(\boldsymbol{X})$ Left inverse: $(\boldsymbol{SX})^{\dagger} = (\boldsymbol{X}^{T}\boldsymbol{S}^{T}\boldsymbol{SX})^{-1}(\boldsymbol{SX})^{T}$ $\tilde{\boldsymbol{\beta}}$ is an unbiased estimator: $\mathbb{E}_{\boldsymbol{y}}[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}] = \boldsymbol{\beta}_{0}$ Model-Induced Uncertainty Conditioned on Algorithm-Induced Uncertainty (3)

 $\min_{\boldsymbol{\beta}} \|\boldsymbol{S}(\boldsymbol{X}\boldsymbol{\beta} - \boldsymbol{y})\|_2 \text{ has solution } \quad \tilde{\boldsymbol{\beta}} = (\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S}\,\boldsymbol{y}, \quad \mathbb{E}_{\boldsymbol{y}}[\boldsymbol{y}] = \boldsymbol{X}\boldsymbol{\beta}_0$

Summary: Model-induced uncertainty conditioned on \boldsymbol{S}

- Sketching preserves rank: $\operatorname{rank}(\boldsymbol{SX}) = \operatorname{rank}(\boldsymbol{X})$ Left inverse: $(\boldsymbol{SX})^{\dagger} = (\boldsymbol{X}^{T}\boldsymbol{S}^{T}\boldsymbol{SX})^{-1}(\boldsymbol{SX})^{T}$ $\tilde{\boldsymbol{\beta}}$ is an unbiased estimator: $\mathbb{E}_{\boldsymbol{y}}[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}] = \boldsymbol{\beta}_{0}$
- Sketching causes loss of rank: $\operatorname{rank}(\boldsymbol{SX}) < \operatorname{rank}(\boldsymbol{X})$ No left inverse: $(\boldsymbol{X}^{T}\boldsymbol{S}^{T}\boldsymbol{SX})^{-1}$ does not exist $\tilde{\boldsymbol{\beta}}$ is a biased estimator: $\mathbb{E}_{\boldsymbol{y}}[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}] \neq \boldsymbol{\beta}_{0}$ Variance $\operatorname{Var}_{\boldsymbol{y}}[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}]$ is singular

Combined Uncertainty: Uniform Sampling with Replacement (1)

Sampling 2 out of 4 rows:
$$\boldsymbol{S}_{ij} = \sqrt{2} \begin{pmatrix} \boldsymbol{e}_i^T \\ \boldsymbol{e}_j^T \end{pmatrix}$$
, $1 \le i, j \le 4$

$$S_{11}X = \sqrt{2} \begin{pmatrix} 1 & 0 & 0 & 0 \\ 1 & 0 & 0 & 0 \end{pmatrix} \begin{pmatrix} 1 & 0 \\ 0 & 1 \\ 1 & 0 \\ 0 & 0 \end{pmatrix} = \sqrt{2} \begin{pmatrix} 1 & 1 \\ 1 & 1 \end{pmatrix}$$
$$S_{42}X = \sqrt{2} \begin{pmatrix} 0 & 0 & 0 & 1 \\ 0 & 1 & 0 & 0 \end{pmatrix} \begin{pmatrix} 1 & 0 \\ 0 & 1 \\ 1 & 0 \\ 0 & 0 \end{pmatrix} = \sqrt{2} \begin{pmatrix} 0 & 0 \\ 0 & 1 \end{pmatrix}$$

Unbiased estimator of the identity:

$$\mathbb{E}_{\boldsymbol{s}}[\boldsymbol{S}^{\mathsf{T}}\boldsymbol{S}] = \sum_{i=1}^{4} \sum_{j=1}^{4} \frac{1}{16} \boldsymbol{S}_{ij}^{\mathsf{T}} \boldsymbol{S}_{ij} = \boldsymbol{I} = \begin{pmatrix} 1 & & \\ & 1 & \\ & & 1 \end{pmatrix}$$

Combined Uncertainty: Uniform Sampling with Replacement (2)

$$\begin{split} \min_{\boldsymbol{\beta}} \|\boldsymbol{S}(\boldsymbol{X}\boldsymbol{\beta} - \boldsymbol{y})\|_2 \text{ has solution } \quad \tilde{\boldsymbol{\beta}} &= (\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S}\,\boldsymbol{y} \\ \text{Conditional mean: } \quad \mathbb{E}_{\boldsymbol{y}}[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}] &= (\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S}\boldsymbol{X}\boldsymbol{\beta}_0 \end{split}$$

Sequential conditioning:

$$\mathbb{E}[\tilde{\beta}] = \mathbb{E}_{\boldsymbol{s}}\left[\mathbb{E}_{\boldsymbol{y}}\left[\tilde{\beta} \mid \boldsymbol{S}\right]\right] = \mathbb{E}_{\boldsymbol{s}}\left[(\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S}\boldsymbol{X}\right]\beta_{0}$$

Biased estimator:

$$\mathbb{E}_{\boldsymbol{s}}\left[(\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S}\boldsymbol{X}\right] = \sum_{i=1}^{4}\sum_{j=1}^{4}\frac{1}{16}(\boldsymbol{S}_{ij}\boldsymbol{X})^{\dagger}(\boldsymbol{S}_{ij}\boldsymbol{X}) = \frac{1}{16}\begin{pmatrix}12 & 0\\0 & 7\end{pmatrix} \neq \begin{pmatrix}1 & 0\\0 & 1\end{pmatrix}$$

12 out of 16 sketched matrices $S_{ij}X$ are rank deficient

Structural Perturbation Bounds

Exact problem $\min_{\beta} \| \mathbf{X} \boldsymbol{\beta} - \mathbf{y} \|_{2}$ Hat matrix $\mathbf{P}_{\mathbf{x}} = \mathbf{X} (\mathbf{X}^{T} \mathbf{X})^{-1} \mathbf{X}^{T} = \mathbf{X} \mathbf{X}^{\dagger}$ Range $\mathcal{R}(\mathbf{P}_{\mathbf{x}}) = \mathcal{R}(\mathbf{X})$ Solution $\hat{\boldsymbol{\beta}} = \mathbf{X}^{\dagger} \mathbf{y} = \mathbf{X}^{\dagger} \mathbf{P}_{\mathbf{x}} \mathbf{y}$

Exact problem $\min_{\beta} \| \mathbf{X} \boldsymbol{\beta} - \mathbf{y} \|_{2}$ Hat matrix $\mathbf{P}_{\mathbf{x}} = \mathbf{X} (\mathbf{X}^{T} \mathbf{X})^{-1} \mathbf{X}^{T} = \mathbf{X} \mathbf{X}^{\dagger}$ Range $\mathcal{R}(\mathbf{P}_{\mathbf{x}}) = \mathcal{R}(\mathbf{X})$ Solution $\hat{\boldsymbol{\beta}} = \mathbf{X}^{\dagger} \mathbf{y} = \mathbf{X}^{\dagger} \mathbf{P}_{\mathbf{x}} \mathbf{y}$

Perturbed problem $\min_{\beta} \|\boldsymbol{S}(\boldsymbol{X}\beta - \boldsymbol{y})\|_2$ $(\boldsymbol{X}^T \boldsymbol{S}^T \boldsymbol{S} \boldsymbol{X})^{-1}$ does not work!

Exact problem $\min_{\beta} \|\boldsymbol{X}\boldsymbol{\beta} - \boldsymbol{y}\|_2$ Hat matrix $P_x = X(X^T X)^{-1} X^T = X X^{\dagger}$ Range $\mathcal{R}(\boldsymbol{P}_{\boldsymbol{x}}) = \mathcal{R}(\boldsymbol{X})$ Solution $\hat{\boldsymbol{\beta}} = \boldsymbol{X}^{\dagger} \boldsymbol{y} = \boldsymbol{X}^{\dagger} \boldsymbol{P}_{\star} \boldsymbol{y}$ Perturbed problem $\min_{\beta} \|\boldsymbol{S}(\boldsymbol{X}\beta - \boldsymbol{y})\|_2$ $(\mathbf{X}^{T}\mathbf{S}^{T}\mathbf{S}\mathbf{X})^{-1}$ does not work! Comparison Hat matrix^{*} $P = X(SX)^{\dagger}S$ Range $\mathcal{R}(\boldsymbol{P}) \subset \mathcal{R}(\boldsymbol{X}) = \mathcal{R}(\boldsymbol{P}_{\boldsymbol{x}})$ If rank(SX) = rank(X) then $\mathcal{R}(P) = \mathcal{R}(X)$ Solution $\tilde{\boldsymbol{\beta}} = (\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S}\boldsymbol{y} = \boldsymbol{X}^{\dagger}\boldsymbol{P}\boldsymbol{y}$

*More general than [Raskutti, Mahoney 2016]

Example: Hat Matrix, and Comparison Hat Matrix

Design matrix, and Hat matrix:

$$\boldsymbol{X} = \begin{pmatrix} 1 & 0 \\ 0 & 1 \\ 1 & 0 \\ 0 & 0 \end{pmatrix}, \qquad \boldsymbol{P}_{\boldsymbol{X}} = \boldsymbol{X} \boldsymbol{X}^{\dagger} = \begin{pmatrix} \frac{1}{2} & 0 & \frac{1}{2} & 0 \\ 0 & 1 & 0 & 0 \\ \frac{1}{2} & 0 & \frac{1}{2} & 0 \\ 0 & 0 & 0 & 0 \end{pmatrix}$$

Sketching matrix with rank(SX) = rank(X), and Comparison Hat matrix:

$$\boldsymbol{S} = \begin{pmatrix} 1 & 0 & 0 & 0 \\ 0 & 1 & 0 & 0 \end{pmatrix}, \quad \boldsymbol{P} = \boldsymbol{X}(\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S} = \begin{pmatrix} 1 & 0 & 0 & 0 \\ 0 & 1 & 0 & 0 \\ 1 & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 \end{pmatrix}, \quad \boldsymbol{\mathcal{R}}(\boldsymbol{P}) = \boldsymbol{\mathcal{R}}(\boldsymbol{X})$$

Sketching matrix with rank(SX) < rank(X), and Comparison Hat matrix:

$$\boldsymbol{S} = \begin{pmatrix} 1 & 0 & 0 & 0 \\ 0 & 0 & 0 & 1 \end{pmatrix}, \quad \boldsymbol{P} = \boldsymbol{X}(\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S} = \begin{pmatrix} 1 & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 \\ 1 & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 \end{pmatrix}, \quad \mathcal{R}(\boldsymbol{P}) \subset \mathcal{R}(\boldsymbol{X})$$

Exact problem $\min_{\beta} \| \boldsymbol{X} \boldsymbol{\beta} - \boldsymbol{y} \|_{2}$ Hat matrix $\boldsymbol{P}_{\boldsymbol{x}} = \boldsymbol{X} (\boldsymbol{X}^{T} \boldsymbol{X})^{-1} \boldsymbol{X}^{T} = \boldsymbol{X} \boldsymbol{X}^{\dagger}$ Solution $\hat{\boldsymbol{\beta}} = \boldsymbol{X}^{\dagger} \boldsymbol{P}_{\boldsymbol{x}} \boldsymbol{y}$

Perturbed problem $\min_{\beta} \| S(X\beta - y) \|_2$ Comparison Hat matrix $P = X(SX)^{\dagger}S$ Solution $\tilde{\beta} = X^{\dagger}Py$

Difference between perturbed and exact solution

$$ilde{eta} = \hat{eta} + oldsymbol{X}^\dagger (oldsymbol{P} - oldsymbol{P}_{oldsymbol{x}}) oldsymbol{y}$$

proportional to difference between Hat and Comparison Hat matrix

Multiplicative Perturbation Bounds

Ingredients:

Condition number: $\kappa_2(\mathbf{X}) = \|\mathbf{X}\|_2 \|\mathbf{X}^{\dagger}\|_2$ Angle between \mathbf{y} and range (\mathbf{X}) : $0 < \theta < \pi/2$

Relative error in perturbed solution:

$$\frac{\|\tilde{\boldsymbol{\beta}} - \hat{\boldsymbol{\beta}}\|_2}{\|\hat{\boldsymbol{\beta}}\|_2} \leq \underbrace{\frac{\kappa_2(\boldsymbol{X})}{\cos\theta}}_{\text{Amplifier}} \underbrace{\|\boldsymbol{P} - \boldsymbol{P}_{\boldsymbol{x}}\|_2}_{\text{Perturbation}}$$

Least squares solution insensitive to multiplicative perturbations, if

- Matrix X well-conditioned with respect to (left) inversion
- Righthand side y close to range(X)

Tighter than [Drineas, Mahoney, Muthukrishnan, Sarlós 2011]

Model-Induced Uncertainty, Conditioned on Algorithm-Induced uncertainty

Conditioning on **S**: Mean

 $\min_eta \| m{S} m{X}m{eta} - m{S} m{y} \|_2$ has solution $\ \ ilde{m{eta}} = (m{S} m{X})^\dagger m{S} m{y}$

Conditional mean

$$\mathbb{E}_{\boldsymbol{y}}\left[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}\right] = (\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S} \ \mathbb{E}_{\boldsymbol{y}}[\boldsymbol{y}] = (\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S} \ \boldsymbol{X} \ \boldsymbol{\beta}_{0}$$

• If rank(\boldsymbol{SX}) = rank(\boldsymbol{X}) then $\tilde{\boldsymbol{\beta}}$ is unbiased estimator $\mathbb{E}_{\boldsymbol{y}}\left[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}\right] = \underbrace{(\boldsymbol{SX})^{\dagger}(\boldsymbol{SX})}_{\boldsymbol{y}} \boldsymbol{\beta}_{0} = \boldsymbol{\beta}_{0}$

• If $rank(\textbf{\textit{SX}}) < rank(\textbf{\textit{X}})$ then $\tilde{\beta}$ is biased estimator

$$\mathbb{E}_{\mathbf{y}}\left[\tilde{\boldsymbol{\beta}} \mid \boldsymbol{S}\right] = \boldsymbol{\beta}_{0} + \underbrace{\left(\boldsymbol{I} - (\boldsymbol{S}\boldsymbol{X})^{\dagger}(\boldsymbol{S}\boldsymbol{X})\right)}_{\text{Rank deficiency of } \boldsymbol{S}\boldsymbol{X}} \boldsymbol{\beta}_{0}$$

Bias of $\tilde{\beta}$ increases with rank deficiency of **SX**

Conditioning on **S**: Variance

 $\min_{eta} \| m{S} m{X} m{eta} - m{S} m{y} \|_2$ has solution $\ ilde{m{eta}} = m{X}^\dagger m{P} m{y}$

Ingredients:

Hat matrix: $\boldsymbol{P}_{\boldsymbol{X}} = \boldsymbol{X}\boldsymbol{X}^{\dagger}$ Comparison Hat matrix: $\boldsymbol{P} = \boldsymbol{X}(\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S}$ Model variance: $\operatorname{Var}_{\boldsymbol{y}}[\hat{\boldsymbol{\beta}}] = \sigma^{2}(\boldsymbol{X}^{T}\boldsymbol{X})^{-1} = \sigma^{2}\boldsymbol{X}^{\dagger}(\boldsymbol{X}^{\dagger})^{T}$

Conditional variance:

$$\mathbb{V}\operatorname{ar}_{\boldsymbol{y}}\left[\boldsymbol{\tilde{\beta}} \mid \boldsymbol{S}\right] = \sigma^{2} \boldsymbol{X}^{\dagger} \boldsymbol{P} \boldsymbol{P}^{T} (\boldsymbol{X}^{\dagger})^{T}$$
$$= \mathbb{V}\operatorname{ar}_{\boldsymbol{y}}[\boldsymbol{\hat{\beta}}] + \sigma^{2} \boldsymbol{X}^{\dagger} \left(\boldsymbol{P} \boldsymbol{P}^{T} - \boldsymbol{P}_{\boldsymbol{x}}\right) (\boldsymbol{X}^{\dagger})^{T}$$
Deviation of \boldsymbol{P} from orthogonal projector

 P_x is orthogonal projector onto $\mathcal{R}(X)$ with $P_x^{\ T} = P_x = P_x^{\ 2}$

Conditioning on **S**: Summary

 $\begin{array}{l} \min_{\beta} \|\boldsymbol{S}\boldsymbol{X}\beta - \boldsymbol{S}\boldsymbol{y}\|_{2} \text{ has solution } \quad \tilde{\beta} = \boldsymbol{X}^{\dagger}\boldsymbol{P}\boldsymbol{y} \\ \text{Comparison Hat matrix } \quad \boldsymbol{P} = \boldsymbol{X}(\boldsymbol{S}\boldsymbol{X})^{\dagger}\boldsymbol{S} \end{array}$

Model-induced uncertainty of $\tilde{\beta}$ conditioned on **S** governed by rank(**SX**)

- Bias increases with deviation of **SX** from full column-rank
- If $rank(\boldsymbol{SX}) = rank(\boldsymbol{X})$ then $\tilde{\boldsymbol{\beta}}$ is unbiased

• Conditional variance close to model variance, if

P close to being an orthogonal projector onto $\mathcal{R}(\mathbf{X})$ **X** well-conditioned with respect to inversion

• If
$$\mathrm{rank}(\boldsymbol{SX}) < \mathrm{rank}(\boldsymbol{X})$$
 then $\mathbb{V}\mathrm{ar}_{\mathbf{y}}[\widetilde{\boldsymbol{eta}} \mid \boldsymbol{S}]$ is singular

Combined Model-induced and Algorithm-Induced Uncertainty

Combined Uncertainty: Mean

 $\min_eta \| m{S} m{X}m{eta} - m{S} m{y} \|_2$ has solution $\ ilde{m{eta}} = (m{S} m{X})^\dagger m{S} m{y}$

Total mean

$$\mathbb{E}[\tilde{\boldsymbol{\beta}}] = \boldsymbol{\beta}_0 + \mathbb{E}_{\boldsymbol{s}}\left[(\boldsymbol{S}\boldsymbol{X})^{\dagger} (\boldsymbol{S}\boldsymbol{X}) - \boldsymbol{I} \right] \boldsymbol{\beta}_0$$

- Deviation of combined uncertainties from model-induced uncertainties governed by expected deviation of sketched matrix from rank deficiency
- Total bias proportional to expected deviation of **SX** from having full column-rank

Combined Uncertainty: Variance

$$\mathsf{min}_{oldsymbol{eta}} \, \| oldsymbol{S} oldsymbol{X} oldsymbol{eta} - oldsymbol{S} oldsymbol{y} \|_2$$
 has solution $\ ilde{oldsymbol{eta}} = (oldsymbol{S} oldsymbol{X})^\dagger oldsymbol{S} oldsymbol{y}$

Deviation of total variance from model variance

$$\begin{aligned} \mathbb{V}\mathrm{ar}[\tilde{\boldsymbol{\beta}}] &= \mathbb{V}\mathrm{ar}_{\boldsymbol{y}}[\hat{\boldsymbol{\beta}}] + \sigma^{2} \boldsymbol{X}^{\dagger} \mathbb{E}_{\boldsymbol{s}}[\boldsymbol{P}\boldsymbol{P}^{T} - \boldsymbol{P}_{\boldsymbol{x}}] (\boldsymbol{X}^{\dagger})^{T} \\ &+ \mathbb{V}\mathrm{ar}_{\boldsymbol{s}} \left[\left((\boldsymbol{S}\boldsymbol{X})^{\dagger} (\boldsymbol{S}\boldsymbol{X}) - \boldsymbol{I} \right) \boldsymbol{\beta}_{0} \right] \end{aligned}$$

- X[†] E_s[PP^T − P_x] (X[†])^T Expected deviation of P from orthogonal projector onto R(X), amplified by conditioning of X
- $\operatorname{Var}_{\boldsymbol{s}}\left[\left((\boldsymbol{SX})^{\dagger}(\boldsymbol{SX}) \boldsymbol{I}\right) \beta_{0}\right]$ Expected deviation of \boldsymbol{SX} from having full column-rank

Example: Best Case for Uniform Sampling

Columns of Hadamard matrix: Best Coherence

$$\boldsymbol{X} = \begin{pmatrix} 1 & 1 \\ 1 & -1 \\ 1 & 1 \\ 1 & -1 \end{pmatrix}, \qquad \boldsymbol{P}_{\boldsymbol{X}} = \boldsymbol{X} \boldsymbol{X}^{\dagger} = \frac{1}{2} \begin{pmatrix} 1 & 0 & 1 & 0 \\ 0 & 1 & 0 & 1 \\ 1 & 0 & 1 & 0 \\ 0 & 1 & 0 & 1 \end{pmatrix}$$

 \boldsymbol{S} samples 2 rows uniformly and with replacement

• Expected deviation of **SX** from full column-rank

$$\mathbb{E}_{\boldsymbol{s}}\left[(\boldsymbol{S}\boldsymbol{X})^{\dagger}(\boldsymbol{S}\boldsymbol{X})-\boldsymbol{I}
ight]=-rac{4}{16}egin{pmatrix}1&0\0&1\end{pmatrix}$$

• Expected deviation of **P** from orthogonal projector onto $\mathcal{R}(\mathbf{X})$

$$\mathbb{E}_{\mathbf{s}}[\mathbf{P}\mathbf{P}^{T} - \mathbf{P}_{\mathbf{x}}] = \frac{3}{16} \begin{pmatrix} 1 & 0 & 1 & 0 \\ 0 & 1 & 0 & 1 \\ 1 & 0 & 1 & 0 \\ 0 & 1 & 0 & 1 \end{pmatrix}$$

Example: Worst Case for Uniform Sampling

Columns of identity matrix: Worst Coherence

 \boldsymbol{S} samples 2 rows uniformly and with replacement

• Expected deviation of **SX** from full column-rank

$$\mathbb{E}_{\boldsymbol{s}}\left[(\boldsymbol{S}\boldsymbol{X})^{\dagger}(\boldsymbol{S}\boldsymbol{X})-\boldsymbol{I}
ight]=-rac{9}{16}egin{pmatrix}1&0\0&1\end{pmatrix}$$

• Expected deviation of **P** from orthogonal projector onto $\mathcal{R}(\mathbf{X})$

Summary

- Randomized (row) sketching for full column-rank regression
- Exact expressions for uncertainties, induced by model and algorithm, under very general assumptions
- Introduced Comparison Hat matrix, to allow comparison between problems of different dimensions
- Tighter multiplicative perturbation bounds
- Total mean and variance governed by expected deviation of

Sketched matrix from full column-rank Comparison Hat matrix from orthogonal projector

- Examples illustrate applicability
- J.T. Chi and I.C.F. Ipsen,

Randomized Least Squares Regression: Combining Model- and Algorithm-Induced Uncertainties, arXiv:1808.0594

MathJobs.Org

Department of Mathematics, North Carolina State University

Position ID: NCSU-PDRNA [#12087]

Position Title: RTG in Randomized Numerical Analysis, Postdoctoral Fellow Position Type: Postdoctoral Position Location: Raleigh, North Carolina 27695, United States [map] Subject Area: Randomized numerical analysis Application Deadline: 2019/03/15 (posted 2018/06/27) Position Dezeritoin: Acody

The Department of Mathematics at NC State University has an open postdoctoral position under its new NFS funded Research Training Group RFL, OMS-1745654 NR Randomized Numerical Analysis. The position is restricted to US citizens, nationals and permanent residents. The position restricted to US citizens, nationals and permanent esidents. The position rank and a new schell a PhD in mathematics or a closely related discipline awarded after January 1, 2017. An exception to this nule, occasioned for instance by a career interruption, may be requested in the cover letter.

The postdoctoral associate is expected to engage in research related to at least one of the three complementary research thrusts of the project in manimized numerical linear algebra, random nonlinear adversa and global sensitivity analysis. Strengths in applied probability, unitarisat analysis and socientific complexity are at asset. Based on background, experimentary and the strengths and socientific complexity are asset. Based on background, experimentary with the RIC: Alen Alexanderian, Pierre Gremaud, life [psen, Tim Kelley, Arvind Salaba and Rajbh Smith. An academic mentor will be chosen from this group to oversee the postdoc's training and professional development. The postdoc will also glay a leading role in mentioning students associated with some of the project's working groups, Halek will be expected to assist in organizing seminars and activities related to the general research of poartment of Halematics.

This position is for a term of up to three years, contingent upon performance. The starting date is anticipated between January and August 2019. The 11 month salary of \$62,500 includes summer support. In addition, the postdoc will be given an annual travel budget of \$3,000.

Through the mathjobs org system, applicants should submit a cover letter, a CV, a research statement and the names of at least three potential letter writers. Women and members of under-represented minority groups are particularly encouraged to apply. Applications will be evaluated on a rolling basis until the position is filled; please apply as soon as possible. Inquiries may be directed to Pierre Germaud (RTG Director): gremaud@escu.edu.

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